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B TECH (SEM-III) THEORY EXAMINATION 2019-20 FUNDAMENTAL OF ELECTRONICS DEVICES

Time: 3 Hours Total Marks: 100

Note: Attempt all sections. If require any missing data; then choose suitably

SECTION A

1. Attempt all parts of this question

(2X10=20)

- a) Define the semiconductors on the basis of energy band gap with neat sketch?
- b) In a simple cubic lattice find the ratio of intercepts on the three axes by (1, 3, 2) Plane?
- c) What type of semiconductor material is suitable for luminescence effect?
- d) A JFET has drain current of 5 mA. If $I_{DSS} = 10$ mA and $V_{GS \text{ off}} = -6V$ find the value of V_{GS} and V_{P} ?
- e) Why is it not possible to construct a germanium P-N-P-N switching diode?
- f) Define pinch-off voltage? What role does it play in Electronic devices
- g) Define Quasi Fermi level?
- h) What is Bragg's equation?
- i) What properties of a semiconductor are determined from a Hall Effect?
- j) Why MOSFET is known as IGFET?

SECTION B

2. Attempt any three question from this section

(3X10=30)

- a) In an N-type silicon sample, the Fermi Level is 0.3 eV below the conduction band edge. Find the electron and hole concentration in the sample at room temperature. For Si, $E_g=1.1$ eV, $n_i=1.5 \times 10^{10}$ cm⁻³
- b) Describe the solar cell? Why must a solar cell be operated in the fourth quadrant of the junction V-I characteristic?
- c) What do you mean by minority carrier injection and minority carrier extraction? Derive an expression for total current through the diode for either forward or reverse bias.
- d) What is steady state carrier generation? Prove that $\delta n = g_{op} \tau_n$ where g_{op} is optical generation rate and τ_n is the life time of carrier?
- e) What is MESFET? Why MESFET is usually made from GaAs or other compound semiconductor materials rather than from silicon? Enumerate the special features of MESFETs.

SECTION C

3. Attempt any one question from this Section

(10X1=10)

- a) (i) Discuss diffusion and drift of carriers?
 - (ii)Derive the Einstein's relation?
- b) Prove that the concentration of free electrons in an intrinsic semiconductor is given by

$$n = N_c e^{-(E_C - E_F)/kT}$$

4. Attempt any one part of the following:

(10X1=10)

- a) What is meant by carrier lifetime? Derive the continuity equation?
- b) (i) What is the Hall Effect and its application?
- (ii) An N channel JFET has pinch-off voltage of 4.5 and $I_{DSS} = 9$ Ma. At what voltage of V_{GS} will I_{DS} be equal to 3 mA? What is its g_m at this I_{DS} ?

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5. Attempt any one part of the following:

(10X1=10)

- a) What do you mean by forward and reverse biased junction? Give a qualitative description of current flow at the junction? In a PN Junction, the reverse biased current is very small but it is increases abruptly beyond a certain reverse bias, Explain?
- b) (i) Draw the circuit diagram of a CE amplifier in BJT? Explain the mechanism of amplification?
- (ii) Distinguish between Zener breakdown and Avalanche breakdown?

6. Attempt any one part of the following:

(10X1=10)

- a) What are the different modes of operation in MOSFET? Draw the static drain characteristic and transfer characteristic curves for N-channel enhancement type MOSFET?
- b) What is photo-detector? Explain the operation of a p-i-n photo-detector. What are the suitable materials for it? How can it made more sensitive to low level intensity of light?

7. Attempt any one part of the following:

(10X1=10)

- a) What is transferred electron effect? Describe a device based on this effect with suitable diagram in detail. Also draw its characteristics.
- b) (i) Compare Zener diode and tunnel diode?
 - (ii) Explain the Degenerate Semiconductor?